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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To be assigned
Examiner: To be assigned

In Re PATENT APPLICATION of:

Applicant : Katsuaki NAKANE
Serial No.: 10/580,545
Filed: May 26, 2006
For: APPARATUS FOR GRADING AND
COMPOSITIONAL ESSAYS
Atty Ref.: SATO 134NP

**INFORMATION
DISCLOSURE
STATEMENT**

August 3, 2006

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(3), i.e., prior to a first Office Action on the merits.

Submitted herewith are copies of a Japanese publication and an English-language article previously cited in the specification of the above application. Also attached is an English-language abstract of the Japanese publication, from which any relevance may be gleaned. Any relevance of the English-language article is self-evident. The documents are listed on the attached form PTO-1449.

Since this Information Disclosure Statement is being filed before a first Office Action, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to all documents listed. Consideration of the listed documents respectfully is requested.

Should any fee be required, however, the Commissioner is hereby authorized to charge such fee to our Deposit Account No. 18-0002 and notify us accordingly.

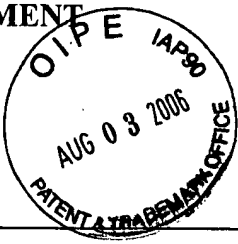
Respectfully submitted,

Steven M. Rabin – Reg. No. 29, 102
RABIN & BERDO, PC – Customer No. 23995
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Telephone: (202) 371-8976

August 3, 2006
Date

SMR:klc

FEE ENCLOSED:\$0
Please charge any further
fee to our Deposit Account
No. 18-0002

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT			Atty. Docket: SATO 134 NP		Application No.: 10/850,545 580		
			Applicant: Katsuaki NAKANE				
			Filing Date: May 26, 2006		Group Art Unit: To be assigned		
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub- Class	Trans- Lation
	AI						
	AJ						
	AK						
	AL						
	AM						
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AN	Jill Burstein, Martin Chodorow, Claudia Leacock, <i>Criterion Online Essay Evaluation</i> , August 2003, all pages, http://www.mori7.net/patent/bm/iaai03bursteinj.pdf					
	AO	Tsunenori ISHIOKA, Masayuki KAMEDA, <i>System for the Automated grading of Japanese Essays by Computer</i> , pages 1-6, http://www.rd.dnc.ac.jp/tunenori/doc/jerater_ieice.pdf					
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							